

Notice of References Cited		Application/Control No. 10/776,789	Applicant(s)/Patent Under Reexamination BEDNASZ ET AL.	
		Examiner YUWEN PAN	Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,760,582	07-2004	Gaal, Peter	455/423
*	B	US-2007/0216880	09-2007	Qi et al.	355/053
*	C	US-7,286,961	10-2007	Kildal, Per-Simon	702/182
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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